

Document Number: MMA20312BV Rev. 2, 9/2014

**VRoHS** 

# Heterojunction Bipolar Transistor Technology (InGaP HBT)

High Efficiency/Linearity Amplifier

The MMA20312BV is a 2-stage high efficiency, Class AB InGaP HBT amplifier designed for use as a linear driver amplifier in wireless base station applications as well as an output stage in femtocell or repeater applications. It is suitable for applications with frequencies from 1800 to 2200 MHz such as CDMA, TD-SCDMA, PCS, UMTS and LTE at operating voltages from 3 to 5 V. The amplifier is housed in a cost-effective, surface mount QFN plastic package.

• Typical Performance: V<sub>CC</sub> = 5 Vdc, I<sub>CQ</sub> = 70 mA, P<sub>out</sub> = 17 dBm

Frequency	G <sub>ps</sub> (dB)	ACPR (dBc)	PAE (%)	Test Signal
1880 MHz	29.0	-47.4	9.1	TD-SCDMA
1920 MHz	29.0	-46.7	9.0	TD-SCDMA
2010 MHz	27.4	-52.0	9.3	TD-SCDMA
2025 MHz	26.8	-50.0	9.5	TD-SCDMA
2140 MHz	27.0	-51.7	9.4	W-CDMA

## Features

- Frequency: 1800-2200 MHz
- P1dB: 30.5 dBm @ 2140 MHz (CW Application Circuit)
- Power Gain: 26.4 dB @ 2140 MHz (CW Application Circuit)
- OIP3: 44.5 dBm @ 2140 MHz (W-CDMA Application Circuit)
- Active Bias Control (adjustable externally)
- Single 3 to 5 V Supply
- Cost-effective 12-pin, 3 mm QFN Surface Mount Plastic Package
- In Tape and Reel. T1 Suffix = 1,000 Units, 12 mm Tape Width, 7-inch Reel.

Table 1	. Typical	Performance	(1)
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Characteristic	Symbol	1800 MHz	2140 MHz	2200 MHz	Unit
Small-Signal Gain (S21)	Gp	28.8	26.4	25.5	dB
Input Return Loss (S11)	IRL	-17.6	-10.9	-9.7	dB
Output Return Loss (S22)	ORL	-20.3	-14.7	-13.7	dB
Power Output @ 1dB Compression	P1dB	30.5	30.5	30.5	dBm

1.  $V_{CC1} = V_{CC2} = V_{BIAS} = 5$  Vdc,  $T_A = 25^{\circ}C$ , 50 ohm system, CW Application Circuit

## **Table 3. Thermal Characteristics**

Characteristic	Symbol	Value <sup>(2)</sup>	Unit
Thermal Resistance, Junction to Case Case Temperature 86°C, V <sub>CC1</sub> = V <sub>CC2</sub> = V <sub>BIAS</sub> = 5 Vdc	$R_{\theta JC}$	52	°C/W

Table 2. Maximum Ratings Rating

Storage Temperature Range

Junction Temperature

Supply Voltage

Supply Current

**RF Input Power** 

2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to <u>http://www.freescale.com/rf</u>. Select Documentation/Application Notes - AN1955.



MMA20312BV	<b>T1</b>
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1800-2200 MHz, 27.2 dB 30.5 dBm InGaP HBT LINEAR AMPLIFIER



Symbol

V<sub>CC</sub>

Icc

Pin

Tstg

TJ

Value

6

550

14

-65 to +150

175

Unit V

mΑ

dBm

°C

°C



**Table 4. Electrical Characteristics** ( $V_{CC1} = V_{CC2} = V_{BIAS} = 5$  Vdc, 2140 MHz,  $T_A = 25^{\circ}$ C, 50 ohm system, in Freescale W-CDMA Application Circuit)

Characteristic	Symbol	Min	Тур	Max	Unit
Small-Signal Gain (S21) <sup>(1)</sup>	Gp	23.6	27.2	—	dB
Input Return Loss (S11)	IRL	—	-10.7	—	dB
Output Return Loss (S22)	ORL	—	-15.5	—	dB
Power Output @ 1dB Compression, CW	P1dB	—	28.2	—	dBm
Third Order Output Intercept Point, Two-Tone CW	OIP3	—	44.5	—	dBm
Noise Figure	NF	—	3.3	—	dB
Supply Current <sup>(1)</sup>	I <sub>CQ</sub>	62.5	70	77	mA
Supply Voltage	V <sub>CC</sub>	_	5	_	V

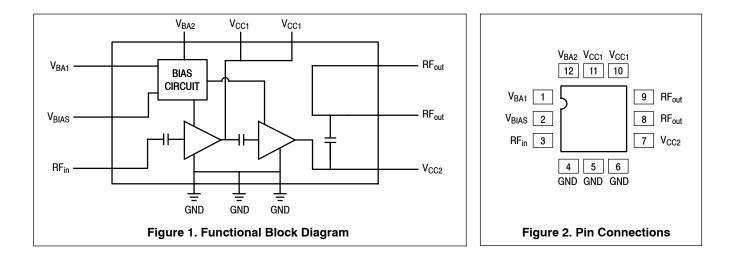
#### **Table 5. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	0, rated to 150 V
Machine Model (per EIA/JESD22-A115)	A
Charge Device Model (per JESD22-C101)	III

## Table 6. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

1. Specified data is based on performance of soldered down part in W-CDMA application circuit.



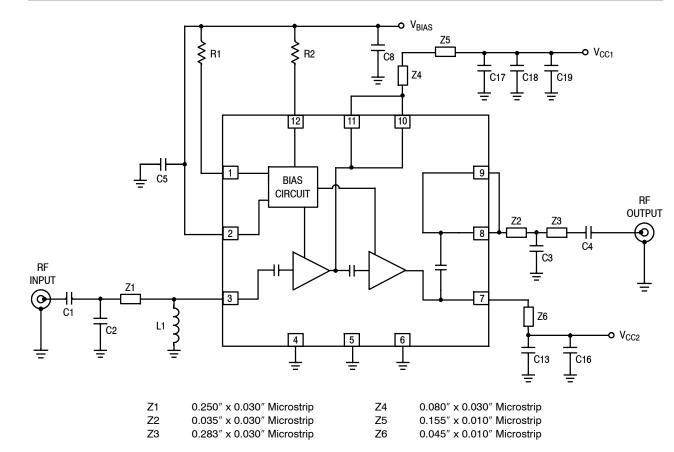


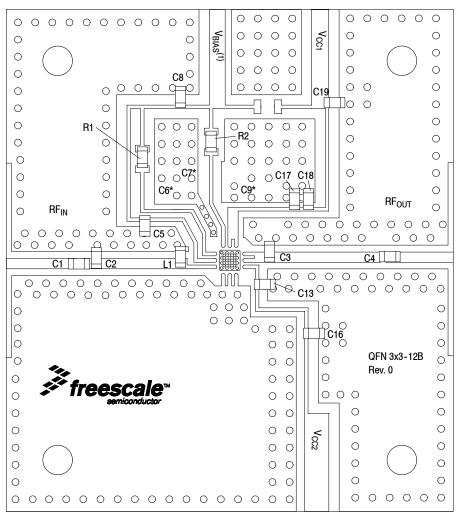
Figure 3. MMA20312BV Test Circuit Schematic — TD-SCDMA, 5 Volt Operation

Table 7. MMA20312BV Test Circuit Co	mponent Designations and Values —	- TD-SCDMA, 5 Volt Operation

Part	Description	Part Number	Manufacturer
C1, C5	22 pF Chip Capacitors	06033J220GBS	AVX
C2	1.8 pF Chip Capacitor	06035J1R8BBS	AVX
C3	2.2 pF Chip Capacitor	06035J2R2BBS	AVX
C4	5.6 pF Chip Capacitor	06035J5R6BBS	AVX
C6, C7, C9	Components Not Placed		
C8, C18	1 μF Chip Capacitors	GRM188R61A105KA61	Murata
C13	10 pF Chip Capacitor	06035J100GBS	AVX
C16, C19	10 μF Chip Capacitors	GRM188R60J106ME47	Murata
C17	0.1 μF Chip Capacitor	GRM188R71H104KA93	Murata
L1	1.8 nH Chip Inductor	LL1608-FS1N8S	TOKO
R1	330 $\Omega$ Chip Resistor	RR0816Q-331-D	Susumu
R2	1.5 kΩ Chip Resistor	RR0816Q-152-D	Susumu
PCB	0.01″, ε <sub>r</sub> = 3.38	680-338	Isola

Note: Component numbers C6, C7 and C9 are labeled on board but not placed. C10, C11, C12, C14 and C15 are intentionally omitted.





V<sub>BIAS</sub> [Board] supplies V<sub>BA1</sub>, V<sub>BA2</sub> and V<sub>BIAS</sub> [Device].
 Note: Component numbers C6\*, C7\* and C9\* are labeled on board but not placed.

Figure 4 MMA20312BV Test Circuit Com	ponent Layout — TD-SCDMA, 5 Volt Operation
Figure 4. WWA20312BV Test Circuit Com	ponent Layout — TD-SCDWA, 5 Volt Operation

Table 7. MMA20312BV Test Circuit Component Designations and Values — TD-SCDMA, 5 Volt Operation

Part	Description	Part Number	Manufacturer
C1, C5	22 pF Chip Capacitors	06033J220GBS	AVX
C2	1.8 pF Chip Capacitor	06035J1R8BBS	AVX
C3	2.2 pF Chip Capacitor	06035J2R2BBS	AVX
C4	5.6 pF Chip Capacitor	06035J5R6BBS	AVX
C6, C7, C9	Components Not Placed		
C8, C18	1 μF Chip Capacitors	GRM188R61A105KA61	Murata
C13	10 pF Chip Capacitor	06035J100GBS	AVX
C16, C19	10 μF Chip Capacitors	GRM188R60J106ME47	Murata
C17	0.1 μF Chip Capacitor	GRM188R71H104KA93	Murata
L1	1.8 nH Chip Inductor	LL1608-FS1N8S	ТОКО
R1	330 $\Omega$ Chip Resistor	RR0816Q-331-D	Susumu
R2	1.5 kΩ Chip Resistor	RR0816Q-152-D	Susumu
PCB	0.01″, ε <sub>r</sub> = 3.38	680-338	Isola

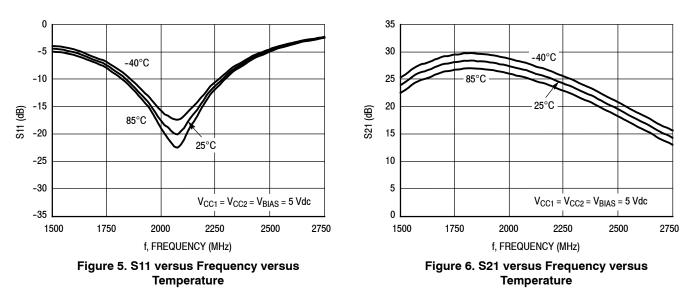
Note: Component numbers C10, C11, C12, C14 and C15 are intentionally omitted.

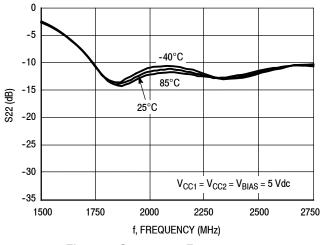
(Test Circuit Component Designations and Values table repeated for reference.)

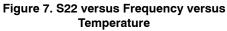
#### MMA20312BVT1



**TYPICAL CHARACTERISTICS — TD-SCDMA** 

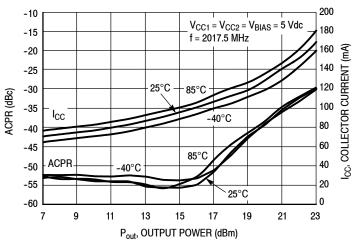








## **TYPICAL CHARACTERISTICS — TD-SCDMA**





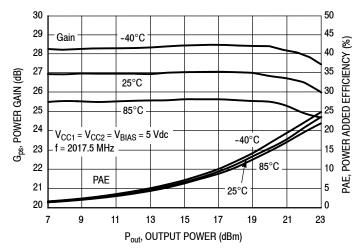
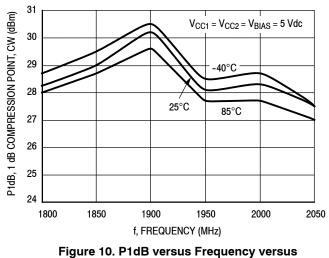


Figure 9. Power Gain versus Power Added Efficiency versus Output Power versus Temperature



Temperature, CW

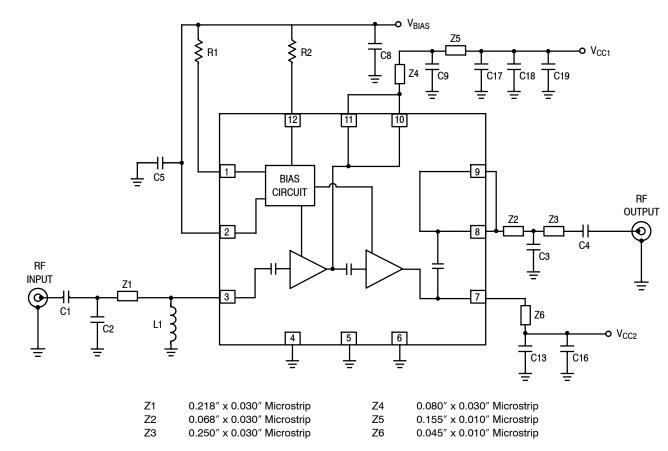
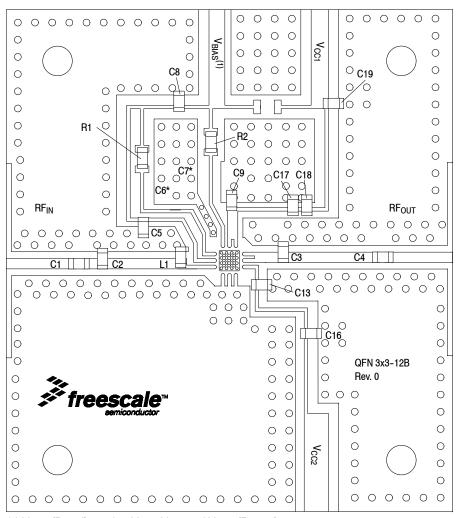


Figure 11. MMA20312BV Test Circuit Schematic — W-CDMA, 5 Volt Operation

Part	Description	Part Number	Manufacturer
C1, C5	22 pF Chip Capacitors	06033J220GBS	AVX
C2, C3	1.8 pF Chip Capacitors	06035J1R8BBS	AVX
C4	5.6 pF Chip Capacitor	06035J5R6BBS	AVX
C6, C7	Components Not Placed		
C8, C18	1 μF Chip Capacitors	GRM188R61A105KA61	Murata
C9	100 pF Chip Capacitor	GRM1885C1H101JA01	Murata
C13	10 pF Chip Capacitor	06035J100GBS	AVX
C16, C19	10 μF Chip Capacitors	GRM188R60J106ME47	Murata
C17	0.1 μF Chip Capacitor	GRM188R71H104KA93	Murata
L1	1.8 nH Chip Inductor	LL1608-FS1N8S	ТОКО
R1	330 $\Omega$ Chip Resistor	RR0816Q-331-D	Susumu
R2	1500 Ω Chip Resistor	RR0816Q-152-D	Susumu
PCB	$0.01'', \epsilon_r = 3.38$	680-338	Isola

Note: Component numbers C6 and C7 are labeled on board but not placed. C10, C11, C12, C14 and C15 are intentionally omitted.





(1)  $V_{BIAS}$  [Board] supplies  $V_{BA1}$ ,  $V_{BA2}$  and  $V_{BIAS}$  [Device].

Note: Component numbers C6\* and C7\* are labeled on board but not placed.

Table 8. MMA20312BV Test Circuit Compo	nent Designations and Values — W-CDMA, 5 Volt Operation

Part	Description	Part Number	Manufacturer	
C1, C5	22 pF Chip Capacitors	06033J220GBS	AVX	
C2, C3	1.8 pF Chip Capacitors	06035J1R8BBS	AVX	
C4	5.6 pF Chip Capacitor	06035J5R6BBS	AVX	
C6, C7	Components Not Placed			
C8, C18	1 μF Chip Capacitors	GRM188R61A105KA61	Murata	
C9	100 pF Chip Capacitor	GRM1885C1H101JA01	Murata	
C13	10 pF Chip Capacitor	06035J100GBS	AVX	
C16, C19	10 μF Chip Capacitors	GRM188R60J106ME47	Murata	
C17	0.1 μF Chip Capacitor	GRM188R71H104KA93	Murata	
L1	1.8 nH Chip Inductor	LL1608-FS1N8S	ТОКО	
R1	330 $\Omega$ Chip Resistor	RR0816Q-331-D	Susumu	
R2	1500 $\Omega$ Chip Resistor	RR0816Q-152-D	Susumu	
PCB	0.01″, ε <sub>r</sub> = 3.38	680-338	Isola	

Note: Component numbers C10, C11, C12, C14 and C15 are intentionally omitted.

(Test Circuit Component Designations and Values table repeated for reference.)



**TYPICAL CHARACTERISTICS — W-CDMA** 

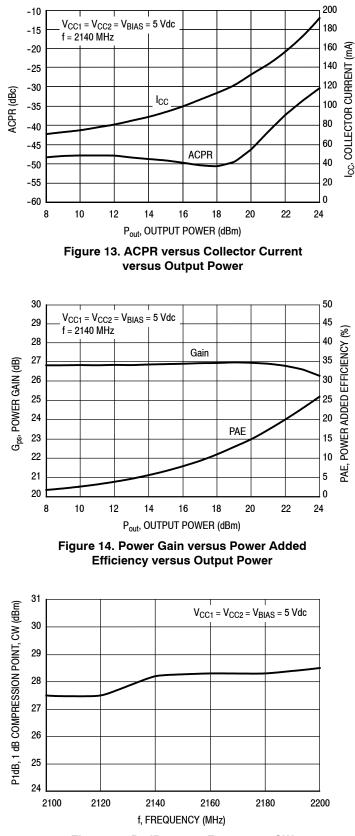
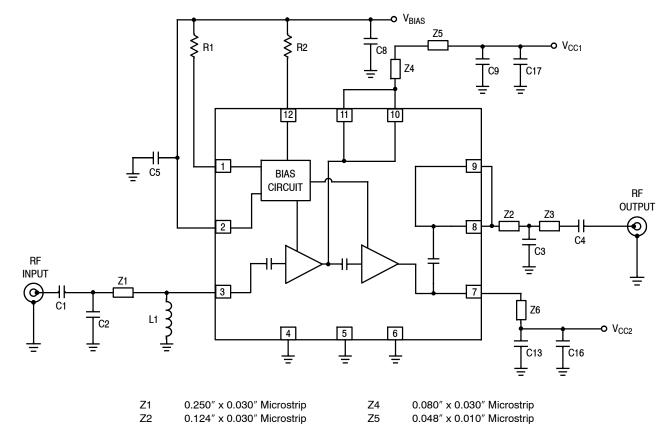


Figure 15. P1dB versus Frequency, CW

RF Device Data Freescale Semiconductor, Inc.



Z3 0.195" x 0.030" Microstrip 0.045" x 0.010" Microstrip

Figure 16. MMA20312BV Test Circuit Schematic — IS-95, 3.3 Volt Operation

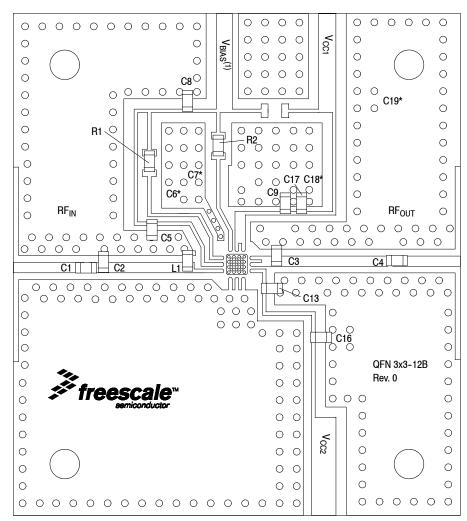
Z6

Table 9. MMA20312BV Test Circuit Com	ponent Designations and Values	- IS-95, 3,3 Volt Operation

Part	Description	Part Number	Manufacturer	
C1, C5, C9	22 pF Chip Capacitors	06033J220GBS	AVX	
C2	2.2 pF Chip Capacitor	06035J2R2BBS	AVX	
C3	2.4 pF Chip Capacitor	06035J2R4BBS	AVX	
C4	4.7 pF Chip Capacitor	06035J4R7BBS	AVX	
C6, C7, C18, C19	Components Not Placed			
C8, C17	1 µF Chip Capacitors	GRM188R61A105KA61	Murata	
C13	10 pF Chip Capacitor	06035J100GBS	AVX	
C16	4.7 μF Chip Capacitor	GRM188R60J106ME47	Murata	
L1	1.5 nH Chip Inductor	LL1608-FS1N5S	ТОКО	
R1	82 $\Omega$ Chip Resistor	RR0816Q-820-D	Susumu	
R2	510 Ω Chip Resistor	RR0816Q-511-D	Susumu	
PCB	0.01″, ε <sub>r</sub> = 3.38	680-338	Isola	

Note: Component numbers C6, C7, C18 and C19 are labeled on board but not placed. C10, C11, C12, C14 and C15 are intentionally omitted.





(1) V<sub>BIAS</sub> [Board] supplies V<sub>BA1</sub>, V<sub>BA2</sub> and V<sub>BIAS</sub> [Device].

Note: Component numbers C6\*, C7\*, C18\* and C19\* are labeled on board but not placed.

Figure 17. MMA20312BV Test Circuit Com	ponent Layout — IS-95, 3.3 Volt Operation
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Table 9. MMA20312BV Test Circuit Comr	oonent Designations and Values — IS-95, 3.3 Volt Operation	on

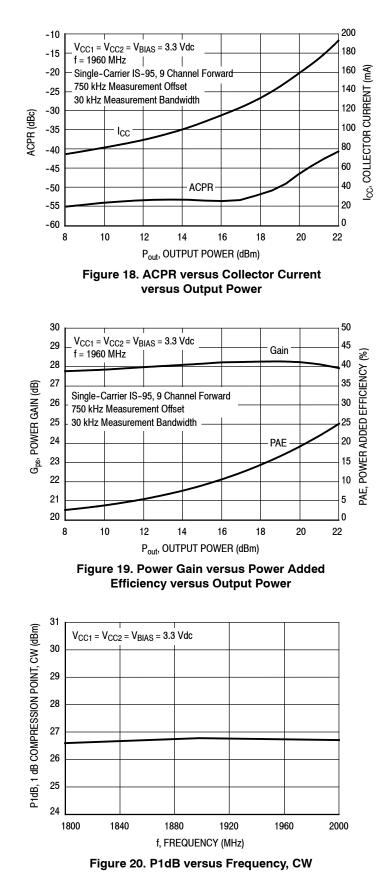
Part	Description	Part Number	Manufacturer
C1, C5, C9	22 pF Chip Capacitors	06033J220GBS	AVX
C2	2.2 pF Chip Capacitor	06035J2R2BBS	AVX
C3	2.4 pF Chip Capacitor	06035J2R4BBS	AVX
C4	4.7 pF Chip Capacitor	06035J4R7BBS	AVX
C6, C7, C18, C19	Components Not Placed		
C8, C17	1 μF Chip Capacitors	GRM188R61A105KA61	Murata
C13	10 pF Chip Capacitor	06035J100GBS	AVX
C16	4.7 µF Chip Capacitor	GRM188R60J106ME47	Murata
L1	1.5 nH Chip Inductor	LL1608-FS1N5S	ТОКО
R1	82 Ω Chip Resistor	RR0816Q-820-D	Susumu
R2	510 $\Omega$ Chip Resistor	RR0816Q-511-D	Susumu
PCB	0.01″, ε <sub>r</sub> = 3.38	680-338	Isola

Note: Component numbers C10, C11, C12, C14 and C15 are intentionally omitted.

(Test Circuit Component Designations and Values table repeated for reference.)



## **TYPICAL CHARACTERISTICS — IS-95**



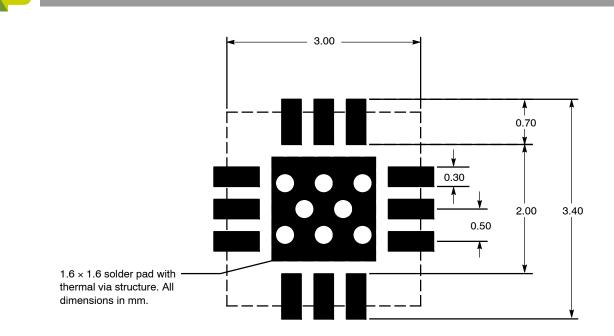


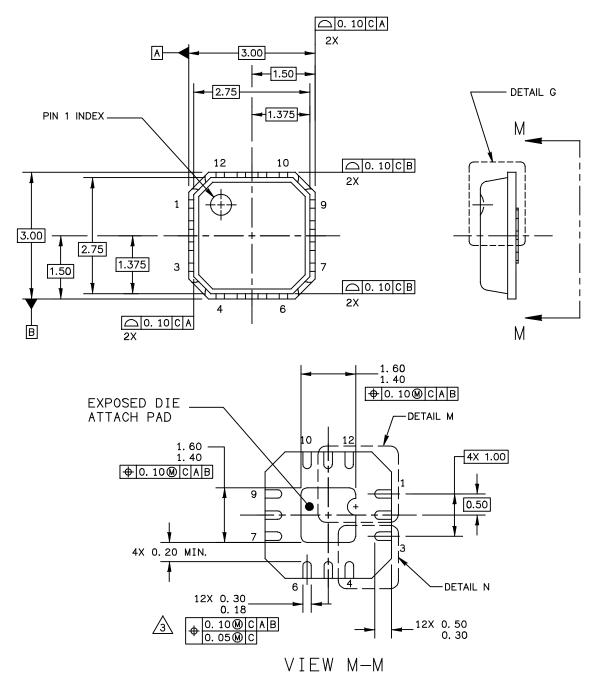




Figure 22. Product Marking

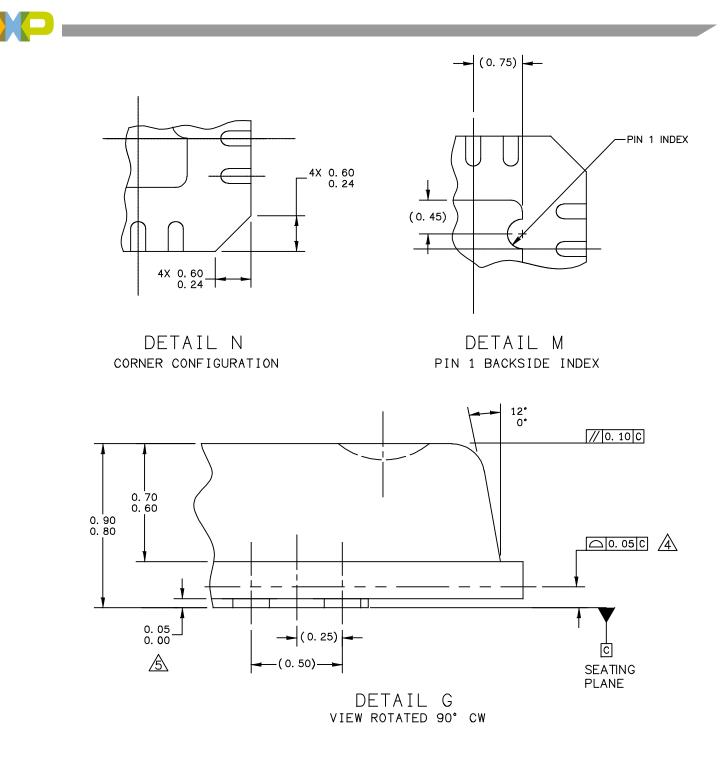


PACKAGE DIMENSIONS



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TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 12 TERMINAL, 0.5 PITCH (3X3X0.85)		DOCUMENT NO	: 98ASA00227D	REV: O
		CASE NUMBER	2131-01	14 MAY 2010
		STANDARD: NO	N-JEDEC	

## MMA20312BVT1



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		CASE NUMBER	8:2131-01	14 MAY 2010
		STANDARD: NO	N-JEDEC	



NOTE:

- 1. ALL DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING & TOLERANCING PER ASME Y14.5 2009.
- THIS DIMENSION APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM TERMINAL TIP.
- $\checkmark$  BILATERAL COPLANARITY ZONE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- $\sqrt{5}$ . This dimension applied only for terminals.

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TITLE: THERMALLY ENHANCED QUAD FLAT NON-LEADED PACKAGE (QFN) 12 TERMINAL, 0.5 PITCH (3X3X0.85)		DOCUMENT NO	): 98ASA00227D	REV: 0
		CASE NUMBER	8: 2131–01	14 MAY 2010
		STANDARD: NON-JEDEC		

## MMA20312BVT1



## **PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS**

Refer to the following resources to aid your design process.

**Application Notes** 

AN1955: Thermal Measurement Methodology of RF Power Amplifiers

- Software
- .s2p File

**Development Tools** 

· Printed Circuit Boards

For Software and Tools, do a Part Number search at http://www.freescale.com, and select the "Part Number" link. Go to Software & Tools on the part's Product Summary page to download the respective tool.

## FAILURE ANALYSIS

At this time, because of the physical characteristics of the part, failure analysis is limited to electrical signature analysis. In cases where Freescale is contractually obligated to perform failure analysis (FA) services, full FA may be performed by third party vendors with moderate success. For updates contact your local Freescale Sales Office.

## **REVISION HISTORY**

The following table summarizes revisions to this document.

Revision	Date	Description
0	Aug. 2011	Initial Release of Data Sheet
1	Dec. 2011	<ul> <li>Updated minimum operating voltage from 3.3 V to 3 V to reflect actual device capability, p. 1</li> <li>All references to "V<sub>CTRL</sub>" in the data sheet tables, test circuit schematics and component layouts is replaced with "V<sub>BIAS</sub>". V<sub>BIAS</sub> is the supply voltage which sets the internal bias conditions via pins 1, 2, and 12, pp. 1–3, 5–7, 9, 10, 12. Footnote "(1) V<sub>BIAS</sub> [Board] supplies V<sub>BA1</sub>, V<sub>BA2</sub> and V<sub>BIAS</sub> [Device]" added to test circuit component layouts, pp. 4, 8, 11.</li> </ul>
2	Sept. 2014	<ul> <li>Table 2, Maximum Ratings: updated Junction Temperature from 150°C to 175°C to reflect recent test results of the device, p. 1</li> <li>Added Failure Analysis information, p. 17</li> </ul>



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